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The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	4160
Number of Logic Elements/Cells	37440
Total RAM Bits	1548288
Number of I/O	309
Number of Gates	1800000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	484-FBGA, CSPBGA
Supplier Device Package	484-CSPBGA (19x19)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3sd1800a-4cs484li

Table 11: DC Characteristics of User I/Os Using Single-Ended Standards

IOSTANDARD Attribute	Test Conditions		Logic Level Characteristics		
	I _{OL} (mA)	I _{OH} (mA)	V _{OL} Max (V)	V _{OH} Min (V)	
LVTTL ⁽³⁾	2	2	-2	0.4	2.4
	4	4	-4		
	6	6	-6		
	8	8	-8		
	12	12	-12		
	16	16	-16		
	24	24	-24		
LVCMOS33 ⁽³⁾	2	2	-2	0.4	V _{CCO} - 0.4
	4	4	-4		
	6	6	-6		
	8	8	-8		
	12	12	-12		
	16	16	-16		
	24 ⁽⁵⁾	24	-24		
LVCMOS25 ⁽³⁾	2	2	-2	0.4	V _{CCO} - 0.4
	4	4	-4		
	6	6	-6		
	8	8	-8		
	12	12	-12		
	16 ⁽⁵⁾	16	-16		
	24 ⁽⁵⁾	24	-24		
LVCMOS18 ⁽³⁾	2	2	-2	0.4	V _{CCO} - 0.4
	4	4	-4		
	6	6	-6		
	8	8	-8		
	12 ⁽⁵⁾	12	-12		
	16 ⁽⁵⁾	16	-16		
LVCMOS15 ⁽³⁾	2	2	-2	0.4	V _{CCO} - 0.4
	4	4	-4		
	6	6	-6		
	8 ⁽⁵⁾	8	-8		
	12 ⁽⁵⁾	12	-12		
LVCMOS12 ⁽³⁾	2	2	-2	0.4	V _{CCO} - 0.4
	4 ⁽⁵⁾	4	-4		
	6 ⁽⁵⁾	6	-6		

Table 11: DC Characteristics of User I/Os Using Single-Ended Standards (Cont'd)

IOSTANDARD Attribute	Test Conditions		Logic Level Characteristics	
	I _{OL} (mA)	I _{OH} (mA)	V _{OL} Max (V)	V _{OH} Min (V)
PCI33_3 ⁽⁴⁾	1.5	-0.5	10% V _{CCO}	90% V _{CCO}
PCI66_3 ⁽⁴⁾	1.5	-0.5	10% V _{CCO}	90% V _{CCO}
HSTL_I ⁽⁵⁾	8	-8	0.4	V _{CCO} - 0.4
HSTL_III ⁽⁵⁾	24	-8	0.4	V _{CCO} - 0.4
HSTL_I_18	8	-8	0.4	V _{CCO} - 0.4
HSTL_II_18 ⁽⁵⁾	16	-16	0.4	V _{CCO} - 0.4
HSTL_III_18	24	-8	0.4	V _{CCO} - 0.4
SSTL18_I	6.7	-6.7	V _{TT} - 0.475	V _{TT} + 0.475
SSTL18_II ⁽⁵⁾	13.4	-13.4	V _{TT} - 0.603	V _{TT} + 0.603
SSTL2_I	8.1	-8.1	V _{TT} - 0.61	V _{TT} + 0.61
SSTL2_II ⁽⁵⁾	16.2	-16.2	V _{TT} - 0.81	V _{TT} + 0.81
SSTL3_I	8	-8	V _{TT} - 0.6	V _{TT} + 0.6
SSTL3_II ⁽⁵⁾	16	-16	V _{TT} - 0.8	V _{TT} + 0.8

Notes:

- The numbers in this table are based on the conditions set forth in [Table 7](#) and [Table 10](#).
- Descriptions of the symbols used in this table are as follows:
 I_{OL}—the output current condition under which V_{OL} is tested
 I_{OH}—the output current condition under which V_{OH} is tested
 V_{OL}—the output voltage that indicates a Low logic level
 V_{OH}—the output voltage that indicates a High logic level
 V_{CCO}—the supply voltage for output drivers
 V_{TT}—the voltage applied to a resistor termination
- For the LVCMOS and LVTTL standards: the same V_{OL} and V_{OH} limits apply for the Fast, Slow, and QUIETIO slew attributes.
- Tested according to the relevant PCI specifications. For information on PCI IP solutions, see www.xilinx.com/products/design_resources/conn_central/protocols/pci_pcix.htm. The PCIX IOSTANDARD is available and has equivalent characteristics but no PCI-X IP is supported.
- These higher-drive output standards are supported only on FPGA banks 1 and 3. Inputs are unrestricted. See the *Using I/O Resources* chapter in [UG331](#).

Differential Output Pairs

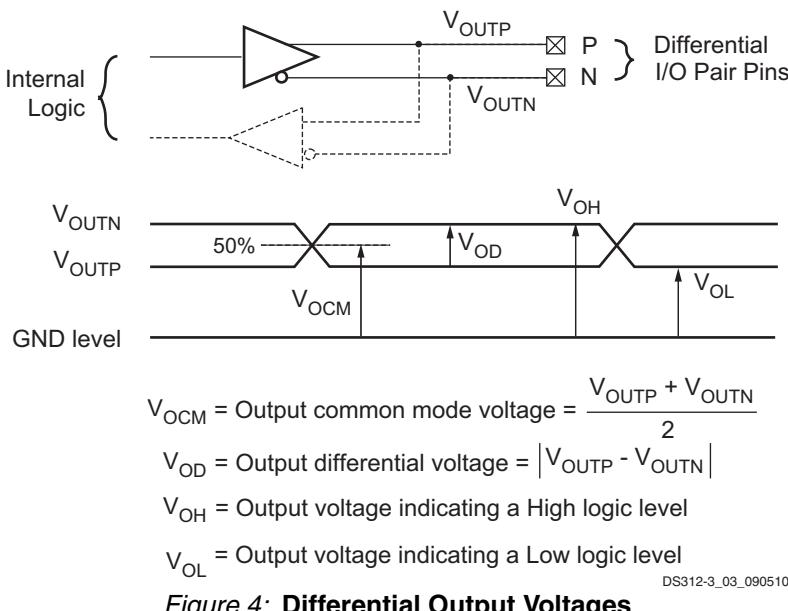


Figure 4: Differential Output Voltages

Table 13: DC Characteristics of User I/Os Using Differential Signal Standards

IOSTANDARD Attribute	V _{OD}			V _{OCM}			V _{OH}	V _{OL}
	Min (mV)	Typ (mV)	Max (mV)	Min (V)	Typ (V)	Max (V)	Min (V)	Max (V)
LVDS_25	247	350	454	1.125	—	1.375	—	—
LVDS_33	247	350	454	1.125	—	1.375	—	—
BLVDS_25	240	350	460	—	1.30	—	—	—
MINI_LVDS_25	300	—	600	1.0	—	1.4	—	—
MINI_LVDS_33	300	—	600	1.0	—	1.4	—	—
RSDS_25	100	—	400	1.0	—	1.4	—	—
RSDS_33	100	—	400	1.0	—	1.4	—	—
TMDS_33	400	—	800	V _{CCO} – 0.405	—	V _{CCO} – 0.190	—	—
PPDS_25	100	—	400	0.5	0.8	1.4	—	—
PPDS_33	100	—	400	0.5	0.8	1.4	—	—
DIFF_HSTL_I_18	—	—	—	—	—	—	V _{CCO} – 0.4	0.4
DIFF_HSTL_II_18	—	—	—	—	—	—	V _{CCO} – 0.4	0.4
DIFF_HSTL_III_18	—	—	—	—	—	—	V _{CCO} – 0.4	0.4
DIFF_HSTL_I	—	—	—	—	—	—	V _{CCO} – 0.4	0.4
DIFF_HSTL_III	—	—	—	—	—	—	V _{CCO} – 0.4	0.4
DIFF_SSTL18_I	—	—	—	—	—	—	V _{TT} + 0.475	V _{TT} – 0.475
DIFF_SSTL18_II	—	—	—	—	—	—	V _{TT} + 0.603	V _{TT} – 0.603
DIFF_SSTL2_I	—	—	—	—	—	—	V _{TT} + 0.61	V _{TT} – 0.61
DIFF_SSTL2_II	—	—	—	—	—	—	V _{TT} + 0.81	V _{TT} – 0.81
DIFF_SSTL3_I	—	—	—	—	—	—	V _{TT} + 0.6	V _{TT} – 0.6
DIFF_SSTL3_II	—	—	—	—	—	—	V _{TT} + 0.8	V _{TT} – 0.8

Notes:

- The numbers in this table are based on the conditions set forth in [Table 7](#) and [Table 12](#).
- See ["External Termination Requirements for Differential I/O."](#)
- Output voltage measurements for all differential standards are made with a termination resistor (R_T) of 100Ω across the N and P pins of the differential signal pair.
- At any given time, no more than two of the following differential output standards can be assigned to an I/O bank: LVDS_25, RSDS_25, MINI_LVDS_25, PPDS_25 when $V_{CCO}=2.5V$, or LVDS_33, RSDS_33, MINI_LVDS_33, TMDS_33, PPDS_33 when $V_{CCO}=3.3V$

Table 19: Setup and Hold Times for the IOB Input Path (Cont'd)

Symbol	Description	Conditions	DELAY VALUE	Device	Speed		Units
					-5	-4	
					Min	Min	
$T_{IOICKPD}$	Time from the active transition at the ICLK input of the Input Flip-Flop (IFF) to the point where data must be held at the Input pin. The Input Delay is programmed.	LVCMS25 ⁽³⁾	1	XC3SD1800A	-1.40	-1.40	ns
			2		-2.11	-2.11	ns
			3		-2.48	-2.48	ns
			4		-2.77	-2.77	ns
			5		-2.62	-2.62	ns
			6		-3.06	-3.06	ns
			7		-3.42	-3.42	ns
			8		-3.65	-3.65	ns
		XC3SD3400A	1		-1.31	-1.31	ns
			2		-1.88	-1.88	ns
			3		-2.44	-2.44	ns
			4		-2.89	-2.89	ns
			5		-2.83	-2.83	ns
			6		-3.33	-3.33	ns
			7		-3.63	-3.63	ns
			8		-3.96	-3.96	ns
Set/Reset Pulse Width							
T_{RPW_IOB}	Minimum pulse width to SR control input on IOB	—	—	All	1.33	1.61	ns

Notes:

- The numbers in this table are tested using the methodology presented in [Table 26](#) and are based on the operating conditions set forth in [Table 7](#) and [Table 10](#).
- This setup time requires adjustment whenever a signal standard other than LVCMS25 is assigned to the data Input. If this is true, add the appropriate Input adjustment from [Table 22](#).
- These hold times require adjustment whenever a signal standard other than LVCMS25 is assigned to the data Input. If this is true, subtract the appropriate Input adjustment from [Table 22](#). When the hold time is negative, it is possible to change the data before the clock's active edge.

Table 20: Sample Window (Source Synchronous)

Symbol	Description	Max	Units
T_{SAMP}	Setup and hold capture window of an IOB flip-flop.	The input capture sample window value is highly specific to a particular application, device, package, I/O standard, I/O placement, DCM usage, and clock buffer. Please consult the appropriate Xilinx Answer Record for application-specific values. • Answer Record 30879	ps

Table 21: Propagation Times for the IOB Input Path (Cont'd)

Symbol	Description	Conditions	DELAY_VALUE	Device	Speed Grade		Units
					-5	-4	
					Max	Max	
T_{IOPLI}	The time it takes for data to travel from the Input pin through the IFF latch to the I output with no input delay programmed	LVCMOS25 ⁽²⁾	0	XC3SD1800A	1.79	2.04	ns
				XC3SD3400A	1.65	2.11	ns
T_{IOPLID}	The time it takes for data to travel from the Input pin through the IFF latch to the I output with the input delay programmed	LVCMOS25 ⁽²⁾	1	XC3SD1800A	2.23	2.47	ns
			2		2.81	3.06	ns
			3		3.39	3.86	ns
			4		3.89	4.43	ns
			5		3.83	4.39	ns
			6		4.61	5.32	ns
			7		5.40	6.24	ns
			8		5.93	6.86	ns
			1	XC3SD3400A	2.21	2.67	ns
			2		2.71	3.25	ns
			3		3.58	4.04	ns
			4		4.15	4.62	ns
			5		4.03	4.49	ns
			6		4.57	5.31	ns
			7		5.34	6.18	ns
			8		5.84	6.78	ns

Notes:

1. The numbers in this table are tested using the methodology presented in [Table 26](#) and are based on the operating conditions set forth in [Table 7](#) and [Table 10](#).
2. This propagation time requires adjustment whenever a signal standard other than LVCMOS25 is assigned to the data Input. When this is true, add the appropriate Input adjustment from [Table 22](#).

Output Propagation Times

Table 23: Timing for the IOB Output Path

Symbol	Description	Conditions	Device	Speed Grade		Units
				-5	-4	
				Max	Max	
Clock-to-Output Times						
T _{IOCKP}	When reading from the Output Flip-Flop (OFF), the time from the active transition at the OCLK input to data appearing at the Output pin	LVC MOS25 ⁽²⁾ , 12 mA output drive, Fast slew rate	All	2.87	3.13	ns
Propagation Times						
T _{IOOP}	The time it takes for data to travel from the IOB's O input to the Output pin	LVC MOS25 ⁽²⁾ , 12 mA output drive, Fast slew rate	All	2.78	2.91	ns
Set/Reset Times						
T _{IOSRP}	Time from asserting the OFF's SR input to setting/resetting data at the Output pin	LVC MOS25 ⁽²⁾ , 12 mA output drive, Fast slew rate	All	3.63	3.89	ns
T _{IOGSRQ}	Time from asserting the Global Set Reset (GSR) input on the STARTUP_SPARTAN3A primitive to setting/resetting data at the Output pin			8.62	9.65	ns

Notes:

1. The numbers in this table are tested using the methodology presented in [Table 26](#) and are based on the operating conditions set forth in [Table 7](#) and [Table 10](#).
2. This time requires adjustment whenever a signal standard other than LVC MOS25 with 12 mA drive and Fast slew rate is assigned to the data Output. When this is true, *add* the appropriate Output adjustment from [Table 25](#).

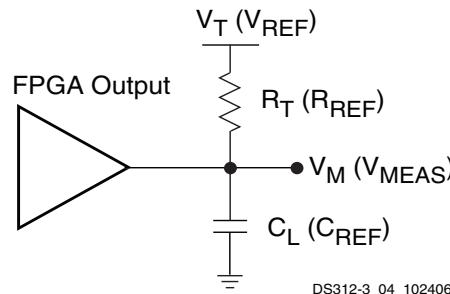
Timing Measurement Methodology

When measuring timing parameters at the programmable I/Os, different signal standards call for different test conditions. [Table 26](#) lists the conditions to use for each standard.

The method for measuring Input timing is as follows: A signal that swings between a Low logic level of V_L and a High logic level of V_H is applied to the Input under test. Some standards also require the application of a bias voltage to the V_{REF} pins of a given bank to properly set the input-switching threshold. The measurement point of the Input signal (V_M) is commonly located halfway between V_L and V_H .

The Output test setup is shown in [Figure 8](#). A termination voltage V_T is applied to the termination resistor R_T , the other end of which is connected to the Output. For each standard, R_T and V_T generally take on the standard values recommended for minimizing signal reflections. If the standard does not ordinarily use terminations (for example,

LVC MOS, LVTTL), then R_T is set to $1M\Omega$ to indicate an open connection, and V_T is set to zero. The same measurement point (V_M) that was used at the Input is also used at the Output.



Notes:

1. The names shown in parentheses are used in the IBIS file.

[Figure 8: Output Test Setup](#)

[Table 26: Test Methods for Timing Measurement at I/Os](#)

Signal Standard (IOSTANDARD)		Inputs			Outputs ⁽²⁾		Inputs and Outputs
		V_{REF} (V)	V_L (V)	V_H (V)	R_T (Ω)	V_T (V)	V_M (V)
Single-Ended							
LV TTL		–	0	3.3	1M	0	1.4
LVC MOS33		–	0	3.3	1M	0	1.65
LVC MOS25		–	0	2.5	1M	0	1.25
LVC MOS18		–	0	1.8	1M	0	0.9
LVC MOS15		–	0	1.5	1M	0	0.75
LVC MOS12		–	0	1.2	1M	0	0.6
PCI33_3	Rising	–	Note 3	Note 3	25	0	0.94
	Falling				25	3.3	2.03
PCI66_3	Rising	–	Note 3	Note 3	25	0	0.94
	Falling				25	3.3	2.03
HSTL_I		0.75	$V_{REF} - 0.5$	$V_{REF} + 0.5$	50	0.75	V_{REF}
HSTL_III		0.9	$V_{REF} - 0.5$	$V_{REF} + 0.5$	50	1.5	V_{REF}
HSTL_I_18		0.9	$V_{REF} - 0.5$	$V_{REF} + 0.5$	50	0.9	V_{REF}
HSTL_II_18		0.9	$V_{REF} - 0.5$	$V_{REF} + 0.5$	25	0.9	V_{REF}
HSTL_III_18		1.1	$V_{REF} - 0.5$	$V_{REF} + 0.5$	50	1.8	V_{REF}
SSTL18_I		0.9	$V_{REF} - 0.5$	$V_{REF} + 0.5$	50	0.9	V_{REF}
SSTL18_II		0.9	$V_{REF} - 0.5$	$V_{REF} + 0.5$	25	0.9	V_{REF}
SSTL2_I		1.25	$V_{REF} - 0.75$	$V_{REF} + 0.75$	50	1.25	V_{REF}
SSTL2_II		1.25	$V_{REF} - 0.75$	$V_{REF} + 0.75$	25	1.25	V_{REF}
SSTL3_I		1.5	$V_{REF} - 0.75$	$V_{REF} + 0.75$	50	1.5	V_{REF}
SSTL3_II		1.5	$V_{REF} - 0.75$	$V_{REF} + 0.75$	25	1.5	V_{REF}

Suspend Mode Timing

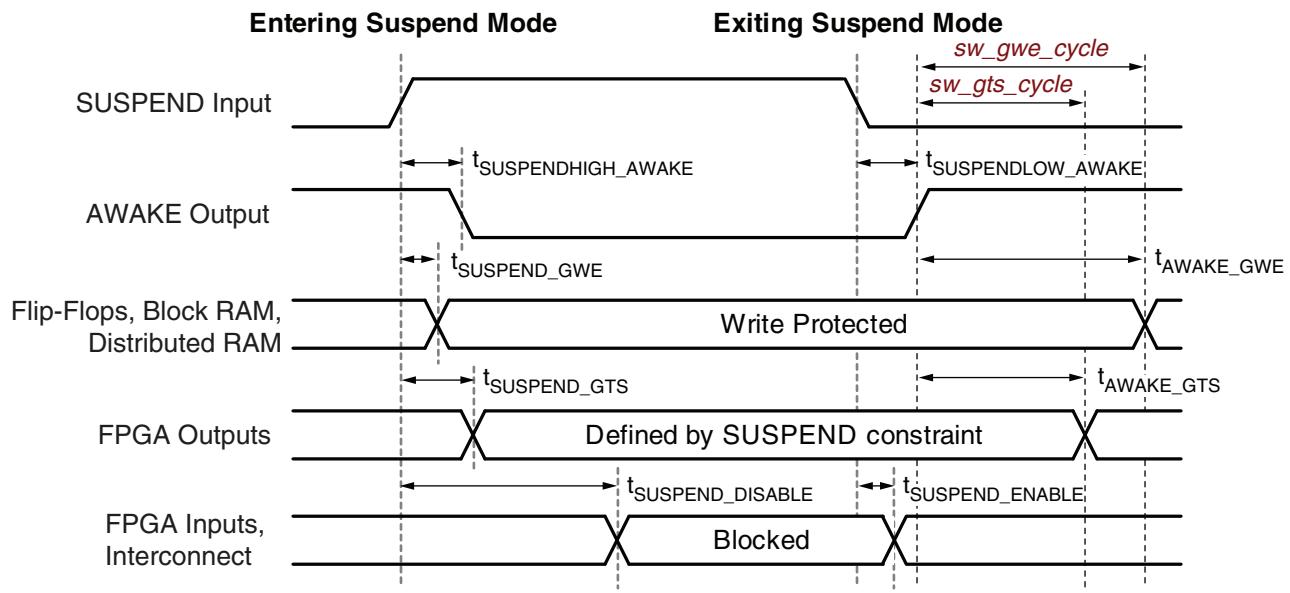


Figure 9: Suspend Mode Timing

DS610-3_08_061207

Table 44: Suspend Mode Timing Parameters

Symbol	Description	Min	Typ	Max	Units
Entering Suspend Mode					
$t_{SUSPENDHIGH_AWAKE}$	Rising edge of SUSPEND pin to falling edge of AWAKE pin without glitch filter (suspend_filter:No)	–	7	–	ns
$t_{SUSPENDFILTER}$	Adjustment to SUSPEND pin rising edge parameters when glitch filter enabled (suspend_filter:Yes)	+160	+300	+600	ns
$t_{SUSPEND_GTS}$	Rising edge of SUSPEND pin until FPGA output pins drive their defined SUSPEND constraint behavior	–	10	–	ns
$t_{SUSPEND_GWE}$	Rising edge of SUSPEND pin to write-protect lock on all writable clocked elements	–	<5	–	ns
$t_{SUSPEND_DISABLE}$	Rising edge of the SUSPEND pin to FPGA input pins and interconnect disabled	–	340	–	ns
Exiting Suspend Mode					
$t_{SUSPENDLOW_AWAKE}$	Falling edge of the SUSPEND pin to rising edge of the AWAKE pin. Does not include DCM lock time.	–	4 to 108	–	μs
$t_{SUSPEND_ENABLE}$	Falling edge of the SUSPEND pin to FPGA input pins and interconnect re-enabled	–	3.7 to 109	–	μs
t_{AWAKE_GWE1}	Rising edge of the AWAKE pin until write-protect lock released on all writable clocked elements, using sw_clk:InternalClock and sw_gwe_cycle:1 .	–	67	–	ns
t_{AWAKE_GWE512}	Rising edge of the AWAKE pin until write-protect lock released on all writable clocked elements, using sw_clk:InternalClock and sw_gwe_cycle:512 .	–	14	–	μs
t_{AWAKE_GTS1}	Rising edge of the AWAKE pin until outputs return to the behavior described in the FPGA application, using sw_clk:InternalClock and sw_gts_cycle:1 .	–	57	–	ns
t_{AWAKE_GTS512}	Rising edge of the AWAKE pin until outputs return to the behavior described in the FPGA application, using sw_clk:InternalClock and sw_gts_cycle:512 .	–	14	–	μs

Notes:

- These parameters based on characterization.
- For information on using the Spartan-3A DSP Suspend feature, see [XAPP480: Using Suspend Mode in Spartan-3 Generation FPGAs](#).

Table 47: Master Mode CCLK Output Frequency by *ConfigRate* Option Setting

Symbol	Description	ConfigRate Setting	Temperature Range	Minimum	Maximum	Units
F_{CCLK1}	Equivalent CCLK clock frequency by <i>ConfigRate</i> setting	1 (power-on value)	Commercial	0.400	0.797	MHz
			Industrial		0.847	MHz
F_{CCLK3}		3	Commercial	1.20	2.42	MHz
			Industrial		2.57	MHz
F_{CCLK6}		6 (default)	Commercial	2.40	4.83	MHz
			Industrial		5.13	MHz
F_{CCLK7}		7	Commercial	2.80	5.61	MHz
			Industrial		5.96	MHz
F_{CCLK8}		8	Commercial	3.20	6.41	MHz
			Industrial		6.81	MHz
F_{CCLK10}		10	Commercial	4.00	8.12	MHz
			Industrial		8.63	MHz
F_{CCLK12}		12	Commercial	4.80	9.70	MHz
			Industrial		10.31	MHz
F_{CCLK13}		13	Commercial	5.20	10.69	MHz
			Industrial		11.37	MHz
F_{CCLK17}		17	Commercial	6.80	13.74	MHz
			Industrial		14.61	MHz
F_{CCLK22}		22	Commercial	8.80	18.44	MHz
			Industrial		19.61	MHz
F_{CCLK25}		25	Commercial	10.00	20.90	MHz
			Industrial		22.23	MHz
F_{CCLK27}		27	Commercial	10.80	22.39	MHz
			Industrial		23.81	MHz
F_{CCLK33}		33	Commercial	13.20	27.48	MHz
			Industrial		29.23	MHz
F_{CCLK44}		44	Commercial	17.60	37.60	MHz
			Industrial		40.00	MHz
F_{CCLK50}		50	Commercial	20.00	44.80	MHz
			Industrial		47.66	MHz
$F_{CCLK100}$		100	Commercial	40.00	88.68	MHz
			Industrial		94.34	MHz

Table 48: Master Mode CCLK Output Minimum Low and High Time

Symbol	Description	ConfigRate Setting															Units		
		1	3	6	7	8	10	12	13	17	22	25	27	33	44	50	100		
T_{MCCL} , T_{MCCH}	Master Mode CCLK Minimum Low and High Time	Commercial	595	196	98.3	84.5	74.1	58.4	48.9	44.1	34.2	25.6	22.3	20.9	17.1	12.3	10.4	5.3	ns
		Industrial	560	185	92.6	79.8	69.8	55.0	46.0	41.8	32.3	24.2	21.4	20.0	16.2	11.9	10.0	5.0	ns

Table 49: Slave Mode CCLK Input Low and High Time

Symbol	Description															Min	Max	Units
T_{SCCL} T_{SCCH}	CCLK Low and High time															5	∞	ns

Byte Peripheral Interface (BPI) Configuration Timing

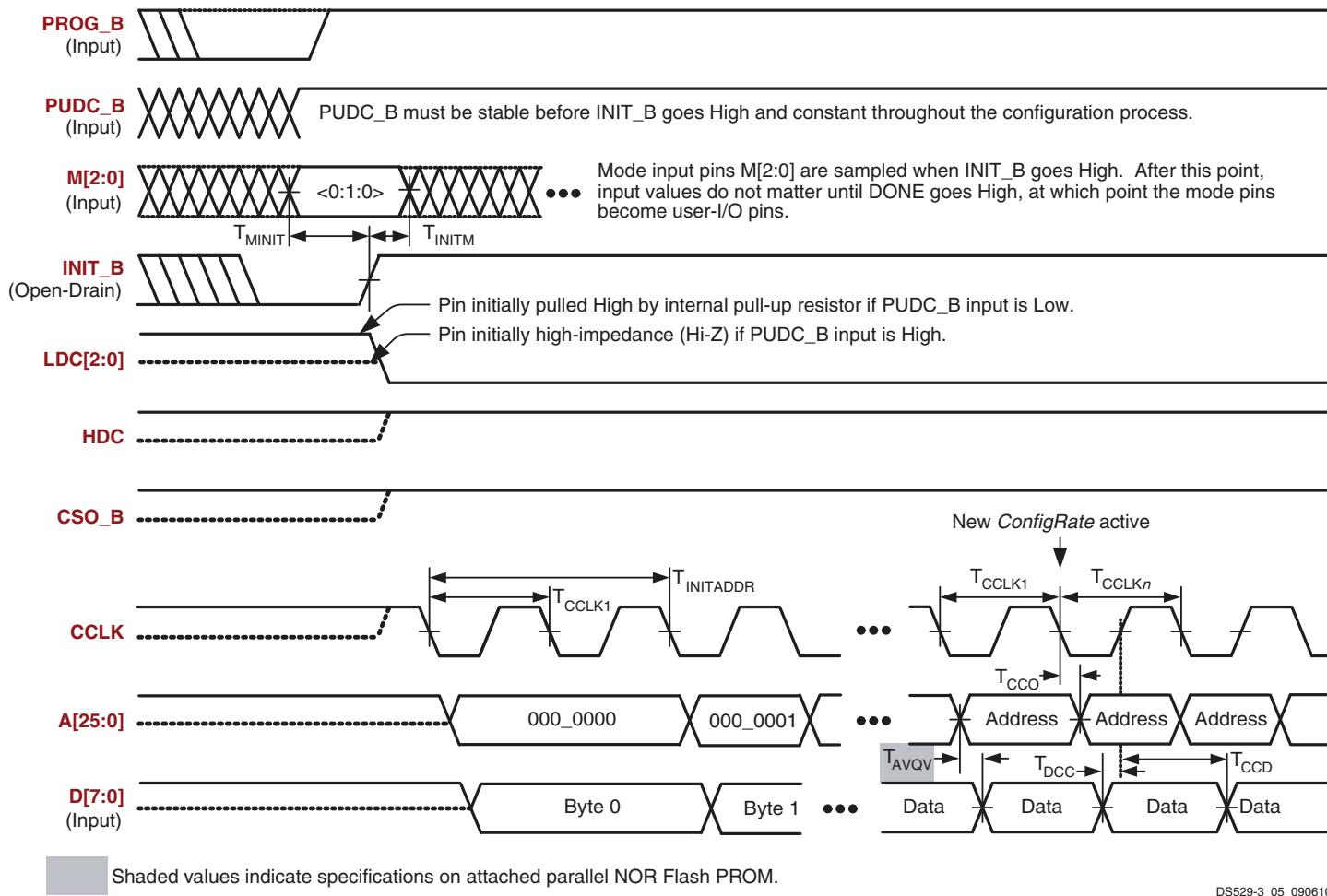


Figure 14: Waveforms for Byte-wide Peripheral Interface (BPI) Configuration

DS529-3_05_090610

Table 54: Timing for Byte-wide Peripheral Interface (BPI) Configuration Mode

Symbol	Description	Minimum	Maximum	Units
T _{CCLK1}	Initial CCLK clock period			See Table 46
T _{CCLKn}	CCLK clock period after FPGA loads ConfigRate setting			See Table 46
T _{MINIT}	Setup time on M[2:0] mode pins before the rising edge of INIT_B	50	—	ns
T _{INITM}	Hold time on M[2:0] mode pins after the rising edge of INIT_B	0	—	ns
T _{INITADDR}	Minimum period of initial A[25:0] address cycle; LDC[2:0] and HDC are asserted and valid	5	5	T _{CCLK1} cycles
T _{CCO}	Address A[25:0] outputs valid after CCLK falling edge			See Table 50
T _{DCC}	Setup time on D[7:0] data inputs before CCLK rising edge			See T _{SMDCC} in Table 51
T _{CCD}	Hold time on D[7:0] data inputs after CCLK rising edge	0	—	ns

IEEE 1149.1/1532 JTAG Test Access Port Timing

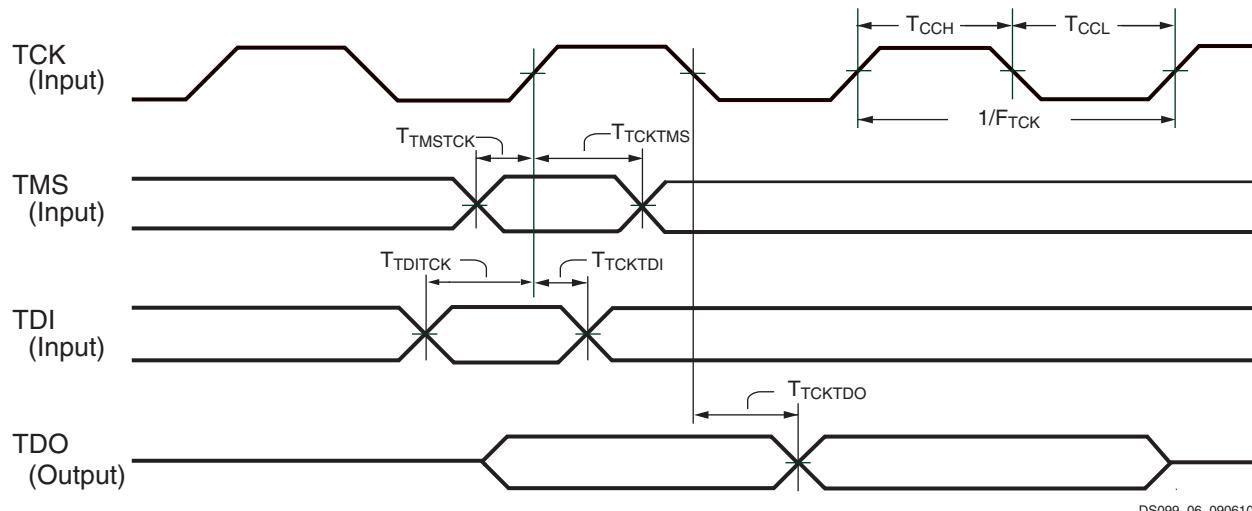


Figure 15: JTAG Waveforms

Table 56: Timing for the JTAG⁽²⁾ Test Access Port

Symbol	Description	All Speed Grades		Units
		Min	Max	
Clock-to-Output Times				
T_{TCKTDO}	The time from the falling transition on the TCK pin to data appearing at the TDO pin	1.0	11.0	ns
Setup Times				
T_{TDITCK}	The time from the setup of data at the TDI pin to the rising transition at the TCK pin	All functions except those shown below	7.0	ns
		Boundary scan commands (INTEST, EXTEST, SAMPLE)	13.0	
T_{TMSTCK}	The time from the setup of a logic level at the TMS pin to the rising transition at the TCK pin	7.0	–	ns
Hold Times				
T_{TCKTDI}	The time from the rising transition at the TCK pin to the point when data is last held at the TDI pin	All functions except those shown below	0	ns
		Configuration commands (CFG_IN, ISC_PROGRAM)	3.5	
T_{TCKTMS}	The time from the rising transition at the TCK pin to the point when a logic level is last held at the TMS pin	0	–	ns
Clock Timing				
T_{CCH}	The High pulse width at the TCK pin	All functions except ISC_DNA command		5 ns
T_{CCL}	The Low pulse width at the TCK pin			5 ns
T_{CCHDNA}	The High pulse width at the TCK pin	During ISC_DNA command		10 ns
T_{CCLDNA}	The Low pulse width at the TCK pin			10 ns
F_{TCK}	Frequency of the TCK signal	BYPASS or HIGHZ instructions		0 MHz
				33 MHz
		All operations except for BYPASS or HIGHZ instructions		20 MHz

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 7.
2. For details on JTAG, see Chapter 9, "JTAG Configuration Mode and Boundary-Scan" in [UG332: Spartan-3 Generation Configuration User Guide](#).

Table 57: Types of Pins on Spartan-3A DSP FPGAs (Cont'd)

Type/Color Code	Description	Pin Name(s) in Type
PWR MGMT	Control and status pins for the power-saving Suspend mode. SUSPEND is a dedicated pin and is powered by VCCAUX. AWAKE is a dual-purpose pin. Unless Suspend mode is enabled in the application, AWAKE is available as a user-I/O pin.	SUSPEND, AWAKE
JTAG	Dedicated JTAG pin - 4 per device. Not available as a user-I/O pin. Every package has four dedicated JTAG pins. These pins are powered by VCCAUX.	TDI, TMS, TCK, TDO
GND	Dedicated ground pin. The number of GND pins depends on the package used. All must be connected.	GND
VCCAUX	Dedicated auxiliary power supply pin. The number of VCCAUX pins depends on the package used. All must be connected. Set on board and using CONFIG VCCAUX constraint.	VCCAUX
VCCINT	Dedicated internal core logic power supply pin. The number of VCCINT pins depends on the package used. All must be connected to +1.2V.	VCCINT
VCCO	Along with all the other VCCO pins in the same bank, this pin supplies power to the output buffers within the I/O bank and sets the input threshold voltage for some I/O standards. All must be connected.	VCCO_#
N.C.	This package pin is not connected in this specific device/package combination but may be connected in larger devices in the same package.	N.C.

Notes:

- # = I/O bank number, an integer between 0 and 3.

Package Pins by Type

Each package has three separate voltage supply inputs—VCCINT, VCCAUX, and VCCO—and a common ground return, GND. The numbers of pins dedicated to these functions vary by package, as shown in [Table 58](#).

Table 58: Power and Ground Supply Pins by Package

Package	Device	VCCINT	VCCAUX	VCCO	GND
CS484	XC3SD1800A	36	24	24	84
	XC3SD3400A	36	24	24	84
FG676	XC3SD1800A	23	14	36	77
	XC3SD3400A	36	24	40	100

A majority of package pins are user-defined I/O or input pins. However, the numbers and characteristics of these I/O depend on the device type and the package in which it is available, as shown in [Table 59](#). The table shows the maximum number of single-ended I/O pins available,

assuming that all [I/O](#)-, [INPUT](#)-, [DUAL](#)-, [VREF](#)-, and [CLK](#)-type pins are used as general-purpose I/O. AWAKE is counted here as a dual-purpose I/O pin. Likewise, the table shows the maximum number of differential pin-pairs available on the package. Finally, the table shows how the total maximum user-I/Os are distributed by pin type, including the number of unconnected—N.C.—pins on the device.

Not all I/O standards are supported on all I/O banks. The left and right banks (I/O banks 1 and 3) support higher output drive current than the top and bottom banks (I/O banks 0 and 2). Similarly, true differential output standards, such as LVDS, RSDS, PPDS, miniLVDS, and TMDS, are only supported in the top or bottom banks (I/O banks 0 and 2). Inputs are unrestricted. For more details, see the [Using I/O Resources](#) chapter in [UG331](#).

Table 59: Maximum User I/O by Package

Package	Device	Maximum User I/Os and Input-Only	Maximum Input-Only	Maximum Differential Pairs	All Possible I/Os by Type					
					I/O	INPUT	DUAL	VREF ⁽¹⁾	CLK	N.C.
CS484	XC3SD1800A	309	60	140	156	41	52	28	32	0
	XC3SD3400A	309	60	140	156	41	52	28	32	0
FG676	XC3SD1800A	519	110	227	314	82	52	39	32	0
	XC3SD3400A	469	60	213	314	34	52	37	32	0

Notes:

- Some VREFs are on INPUT pins. See pinout tables for details.

Package Thermal Characteristics

The power dissipated by an FPGA application has implications on package selection and system design. The power consumed by a Spartan-3A DSP FPGA is reported using either the [XPower Power Estimator](#) or the [XPower Analyzer](#) calculator integrated in the Xilinx ISE® development software. Table 62 provides the thermal characteristics for the various Spartan-3A DSP device package offerings. This information is also available using the [Thermal Query tool](#).

The junction-to-case thermal resistance (θ_{JC}) indicates the difference between the temperature measured on the package body (case) and the die junction temperature per watt of power consumption. The junction-to-board (θ_{JB}) value similarly reports the difference between the board and junction temperature. The junction-to-ambient (θ_{JA}) value reports the temperature difference between the ambient environment and the junction temperature. The θ_{JA} value is reported at different air velocities, measured in linear feet per minute (LFM). The “Still Air (0 LFM)” column shows the θ_{JA} value in a system without a fan. The thermal resistance drops with increasing air flow.

Table 62: Spartan-3A DSP FPGA Package Thermal Characteristics

Package	Device	Junction-to-Case (θ_{JC})	Junction-to-Board (θ_{JB})	Junction-to-Ambient (θ_{JA}) at Different Air Flows				Units
				Still Air (0 LFM)	250 LFM	500 LFM	750 LFM	
CS484 CSG484	XC3SD1800A	4.1	6.8	18.0	13.3	12.3	11.5	°C/W
	XC3SD3400A	3.5	5.6	16.9	12.2	11.0	10.4	°C/W
FG676 FGG676	XC3SD1800A	4.7	7.8	15.9	11.6	10.6	10.0	°C/W
	XC3SD3400A	3.8	6.4	14.7	10.5	9.4	8.9	°C/W

Table 66: Spartan-3A DSP FG676 Pinout for XC3SD1800A FPGA (Cont'd)

Bank	XC3SD1800A Pin Name	FG676 Ball	Type
3	IP_L04P_3	C2	INPUT
3	IO_L02N_3	B1	I/O
3	IO_L02P_3	B2	I/O
3	IP_L66P_3	AE1	INPUT
3	IP_L66N_3/VREF_3	AE2	VREF
3	IO_L65P_3	AD1	I/O
3	IO_L65N_3	AD2	I/O
3	IO_L60N_3	AC1	I/O
3	IO_L64P_3	AC2	I/O
3	IO_L64N_3	AC3	I/O
3	IO_L60P_3	AB1	I/O
3	IO_L55P_3	AA2	I/O
3	IO_L55N_3	AA3	I/O
3	IP_L58N_3/VREF_3	AA5	VREF
3	IP_L16P_3	G2	INPUT
3	IP_L12P_3	G5	INPUT
3	IP_L08P_3	D2	INPUT
3	IP_L62P_3	AB3	INPUT
3	IP_L58P_3	AA4	INPUT
3	IP_L08N_3	D1	INPUT
3	IP_L62N_3	AB4	INPUT
3	IP_L54N_3	Y4	INPUT
3	VCCO_3	W5	VCCO
3	VCCO_3	T2	VCCO
3	VCCO_3	T8	VCCO
3	VCCO_3	P5	VCCO
3	VCCO_3	L2	VCCO
3	VCCO_3	L8	VCCO
3	VCCO_3	H5	VCCO
3	VCCO_3	E2	VCCO
3	VCCO_3	AB2	VCCO
GND	GND	W8	GND
GND	GND	W14	GND
GND	GND	W19	GND
GND	GND	W24	GND
GND	GND	V3	GND
GND	GND	U10	GND
GND	GND	U13	GND
GND	GND	U17	GND

Table 66: Spartan-3A DSP FG676 Pinout for XC3SD1800A FPGA (Cont'd)

Bank	XC3SD1800A Pin Name	FG676 Ball	Type
GND	GND	T1	GND
GND	GND	T6	GND
GND	GND	T12	GND
GND	GND	T14	GND
GND	GND	T16	GND
GND	GND	T21	GND
GND	GND	T26	GND
GND	GND	R11	GND
GND	GND	R13	GND
GND	GND	R15	GND
GND	GND	P12	GND
GND	GND	P16	GND
GND	GND	P19	GND
GND	GND	P24	GND
GND	GND	N3	GND
GND	GND	N8	GND
GND	GND	N11	GND
GND	GND	N15	GND
GND	GND	M12	GND
GND	GND	M14	GND
GND	GND	M16	GND
GND	GND	L1	GND
GND	GND	L6	GND
GND	GND	L11	GND
GND	GND	L13	GND
GND	GND	L15	GND
GND	GND	L21	GND
GND	GND	L26	GND
GND	GND	K10	GND
GND	GND	K17	GND
GND	GND	J24	GND
GND	GND	H3	GND
GND	GND	H8	GND
GND	GND	H14	GND
GND	GND	H19	GND
GND	GND	F1	GND
GND	GND	F6	GND
GND	GND	F11	GND
GND	GND	F16	GND

User I/Os by Bank

Table 67 indicates how the available user-I/O pins are distributed between the four I/O banks on the FG676 package. The AWAKE pin is counted as a dual-purpose I/O.

Table 67: User I/Os Per Bank for the XC3SD1800A in the FG676 Package

Package Edge	I/O Bank	Maximum I/Os and Input-Only	All Possible I/O Pins by Type				
			I/O	INPUT	DUAL	VREF ⁽¹⁾	CLK
Top	0	128	82	28	1	9	8
Right	1	130	67	15	30	10	8
Bottom	2	129	68	21	21	11	8
Left	3	132	97	18	0	9	8
TOTAL		519	314	82	52	39	32

Notes:

- 28 VREF are on INPUT pins.

FG676 Footprint – XC3SD1800A FPGA

Left Half of Package (Top View)

314 I/O: Unrestricted, general-purpose user I/O.

82 INPUT: Unrestricted, general-purpose input pin.

51 DUAL: Configuration pins, then possible user I/O.

39 VREF: User I/O or input voltage reference for bank.

32 CLK: User I/O, input, or clock buffer input.

2 CONFIG: Dedicated configuration pins.

4 JTAG: Dedicated JTAG port pins.

2 SUSPEND: Dedicated SUSPEND and dual-purpose AWAKE Power Management pins

77 GND: Ground

36 VCCO: Output voltage supply for bank.

23 VCCINT: Internal core supply voltage (+1.2V).

14 VCCAUX: Auxiliary supply voltage.

Note: The boxes with triangles inside indicate pin differences from the XC3SD3400A device. Please see the [Footprint Migration Differences](#) section for more information.



Bank 2

Figure 16: FG676 Package Footprint for XC3SD1800A FPGA (Top View–Left Half)

Table 68: Spartan-3A DSP FG676 Pinout for XC3SD3400A FPGA (Cont'd)

Bank	XC3SD3400A Pin Name	FG676 Ball	Type
1	IO_L12N_1	U18	I/O
1	IO_L12P_1	U19	I/O
1	IO_L10N_1	U20	I/O
1	IO_L14P_1	U21	I/O
1	IO_L21N_1	U22	I/O
1	IO_L23P_1	U23	I/O
1	IO_L23N_1/VREF_1	U24	VREF
1	IP_1/VREF_1	U26	VREF
1	IO_L17N_1	T17	I/O
1	IO_L17P_1	T18	I/O
1	IO_L14N_1	T20	I/O
1	IO_L26P_1/A4	T23	DUAL
1	IO_L26N_1/A5	T24	DUAL
1	IO_L27N_1/A7	R17	DUAL
1	IO_L27P_1/A6	R18	DUAL
1	IO_L22P_1	R19	I/O
1	IO_L22N_1	R20	I/O
1	IO_L25P_1/A2	R21	DUAL
1	IO_L25N_1/A3	R22	DUAL
1	IP_L28P_1/VREF_1	R23	VREF
1	IP_L28N_1	R24	INPUT
1	IO_L29P_1/A8	R25	DUAL
1	IO_L29N_1/A9	R26	DUAL
1	IO_L34P_1/IRDY1/RHCLK6	P18	RHCLK
1	IO_L30N_1/RHCLK1	P20	RHCLK
1	IO_L30P_1/RHCLK0	P21	RHCLK
1	IO_L37P_1	P22	I/O
1	IO_L33P_1/RHCLK4	P23	RHCLK
1	IO_L31N_1/TRDY1/RHCLK3	P25	RHCLK
1	IO_L31P_1/RHCLK2	P26	RHCLK
1	IO_L39N_1/A15	N17	DUAL
1	IO_L39P_1/A14	N18	DUAL
1	IO_L34N_1/RHCLK7	N19	RHCLK
1	IO_L42P_1/A16	N20	DUAL
1	IO_L37N_1	N21	I/O
1	IP_L36N_1	N23	INPUT
1	IO_L33N_1/RHCLK5	N24	RHCLK
1	IP_L32N_1	N25	INPUT
1	IP_L32P_1	N26	INPUT

Table 68: Spartan-3A DSP FG676 Pinout for XC3SD3400A FPGA (Cont'd)

Bank	XC3SD3400A Pin Name	FG676 Ball	Type
1	IO_L47N_1	M18	I/O
1	IO_L47P_1	M19	I/O
1	IO_L42N_1/A17	M20	DUAL
1	IO_L45P_1	M21	I/O
1	IO_L45N_1	M22	I/O
1	IO_L38N_1/A13	M23	DUAL
1	IP_L36P_1/VREF_1	M24	VREF
1	IO_L35N_1/A11	M25	DUAL
1	IO_L35P_1/A10	M26	DUAL
1	IO_L55N_1	L17	I/O
1	IO_L55P_1	L18	I/O
1	IO_L53P_1	L20	I/O
1	IO_L50P_1	L22	I/O
1	IP_L40N_1	L23	INPUT
1	IO_L38P_1/A12	L24	DUAL
1	IO_L57N_1	K18	I/O
1	IO_L57P_1	K19	I/O
1	IO_L53N_1	K20	I/O
1	IO_L50N_1	K21	I/O
1	IO_L46N_1	K22	I/O
1	IO_L46P_1	K23	I/O
1	IP_L40P_1	K24	INPUT
1	IO_L41P_1	K25	I/O
1	IO_L41N_1	K26	I/O
1	IO_L59P_1	J19	I/O
1	IO_L59N_1	J20	I/O
1	IO_L62P_1/A20	J21	DUAL
1	IO_L49N_1	J22	I/O
1	IO_L49P_1	J23	I/O
1	IO_L43N_1/A19	J25	DUAL
1	IO_L43P_1/A18	J26	DUAL
1	IO_L64P_1/A24	H20	DUAL
1	IO_L62N_1/A21	H21	DUAL
1	IP_1	H24	INPUT
1	IP_1/VREF_1	H26	VREF
1	IO_L64N_1/A25	G21	DUAL
1	IO_L58N_1	G22	I/O
1	IO_L51P_1	G23	I/O
1	IO_L51N_1	G24	I/O

Table 68: Spartan-3A DSP FG676 Pinout for XC3SD3400A FPGA (Cont'd)

Bank	XC3SD3400A Pin Name	FG676 Ball	Type
2	VCCO_2	AB8	VCCO
2	VCCO_2	AB14	VCCO
2	VCCO_2	AB19	VCCO
3	IO_L53P_3	Y1	I/O
3	IO_L53N_3	Y2	I/O
3	IP_3	Y3	INPUT
3	IO_L57P_3	Y5	I/O
3	IO_L57N_3	Y6	I/O
3	IP_L50P_3	W1	INPUT
3	IP_L50N_3/VREF_3	W2	VREF
3	IO_L52P_3	W3	I/O
3	IO_L52N_3	W4	I/O
3	IO_L63N_3	W6	I/O
3	IO_L63P_3	W7	I/O
3	IO_L47P_3	V1	I/O
3	IO_L47N_3	V2	I/O
3	IP_L46N_3	V4	INPUT
3	IO_L49N_3	V5	I/O
3	IO_L59N_3	V6	I/O
3	IO_L59P_3	V7	I/O
3	IO_L61N_3	V8	I/O
3	IO_L44P_3	U1	I/O
3	IO_L44N_3	U2	I/O
3	IP_L46P_3	U3	INPUT
3	IO_L42N_3	U4	I/O
3	IO_L49P_3	U5	I/O
3	IO_L51N_3	U6	I/O
3	IO_L56P_3	U7	I/O
3	IO_L56N_3	U8	I/O
3	IO_L61P_3	U9	I/O
3	IO_L38P_3	T3	I/O
3	IO_L38N_3	T4	I/O
3	IO_L42P_3	T5	I/O
3	IO_L51P_3	T7	I/O
3	IO_L48N_3	T9	I/O
3	IO_L48P_3	T10	I/O
3	IO_L36P_3/VREF_3	R1	VREF
3	IO_L36N_3	R2	I/O
3	IO_L37P_3	R3	I/O

Table 68: Spartan-3A DSP FG676 Pinout for XC3SD3400A FPGA (Cont'd)

Bank	XC3SD3400A Pin Name	FG676 Ball	Type
3	IO_L37N_3	R4	I/O
3	IO_L40P_3	R5	I/O
3	IO_L40N_3	R6	I/O
3	IO_L45N_3	R7	I/O
3	IO_L45P_3	R8	I/O
3	IO_L43N_3	R9	I/O
3	IO_L43P_3/VREF_3	R10	VREF
3	IO_L33P_3/LHCLK2	P1	LHCLK
3	IO_L33N_3/IRDY2/LHCLK3	P2	LHCLK
3	IO_L34N_3/LHCLK5	P3	LHCLK
3	IO_L34P_3/LHCLK4	P4	LHCLK
3	IO_L39N_3	P6	I/O
3	IO_L39P_3	P7	I/O
3	IO_L41P_3	P8	I/O
3	IO_L41N_3	P9	I/O
3	IO_L35N_3/LHCLK7	P10	LHCLK
3	IO_L31P_3	N1	I/O
3	IO_L31N_3	N2	I/O
3	IO_L30N_3	N4	I/O
3	IO_L30P_3	N5	I/O
3	IO_L32P_3/LHCLK0	N6	LHCLK
3	IO_L32N_3/LHCLK1	N7	LHCLK
3	IO_L35P_3/TRDY2/LHCLK6	N9	LHCLK
3	IO_L29N_3/VREF_3	M1	VREF
3	IO_L29P_3	M2	I/O
3	IO_L27N_3	M3	I/O
3	IO_L27P_3	M4	I/O
3	IO_L28P_3	M5	I/O
3	IO_L28N_3	M6	I/O
3	IO_L26N_3	M7	I/O
3	IO_L26P_3	M8	I/O
3	IO_L21N_3	M9	I/O
3	IO_L21P_3	M10	I/O
3	IO_L25N_3	L3	I/O
3	IO_L25P_3	L4	I/O
3	IO_L18N_3	L7	I/O
3	IO_L15N_3	L9	I/O
3	IO_L15P_3	L10	I/O
3	IP_L24N_3	K1	INPUT

FG676 Footprint – XC3SD3400A FPGA

Left Half of Package (Top View)

314 I/O: Unrestricted, general-purpose user I/O.

34 INPUT: Unrestricted, general-purpose input pin.

51 DUAL: Configuration pins, then possible user I/O.

37 VREF: User I/O or input voltage reference for bank.

32 CLK: User I/O, input, or clock buffer input.

2 CONFIG: Dedicated configuration pins.

2 SUSPEND: Dedicated SUSPEND and dual-purpose AWAKE Power Management pins

4 JTAG: Dedicated JTAG port pins.

100 GND: Ground

40 VCCO: Output voltage supply for bank.

36 VCCINT: Internal core supply voltage (+1.2V).

24 VCCAUX: Auxiliary supply voltage.

Note: The boxes with question marks inside indicate pin differences from the XC3SD1800A device. Please see the Footprint Migration Differences section for more information.



Figure 17: FG676 Package Footprint for XC3SD3400A FPGA (Top View–Left Half)

Table 70: FG676 Footprint Migration Differences (Cont'd)

FG676 Ball	Spartan-3A		Spartan-3A DSP		Spartan-3A DSP		FG676 Ball
	XC3S1400A Type	XC3S1400A Bank	XC3SD1800A Type	XC3SD1800A Bank	XC3SD3400A Type	XC3SD3400A Bank	
Y8	N.C.	N.C.	IP_2	2	VCCINT	VCCINT	Y8
Y11	IP_2	2	IP_2	2	VCCINT	VCCINT	Y11
Y18	N.C.	N.C.	IP_2	2	VCCINT	VCCINT	Y18
Y19	N.C.	N.C.	IP_2/VREF_2	2	VCCINT	VCCINT	Y19
W18	N.C.	N.C.	IP_2	2	VCCINT	VCCINT	W18
AF2	IP_2	2	IP_2	2	VCCAUX	VCCAUX	AF2
AF7	IP_2	2	IP_2	2	VCCO_2	2	AF7
AD5	N.C.	N.C.	IP_2	2	GND	GND	AD5
AD23	N.C.	N.C.	IP_2	2	GND	GND	AD23
AC5	N.C.	N.C.	IP_2	2	GND	GND	AC5
AC7	IP_2	2	IP_2	2	GND	GND	AC7
AC18	IP_2	2	IP_2	2	GND	GND	AC18
AB10	IP_2/VREF_2	2	IP_2/VREF_2	2	GND	GND	AB10
AB17	IP_2	2	IP_2	2	VCCAUX	VCCAUX	AB17
AB20	IP_2	2	IP_2	2	GND	GND	AB20
AA8	N.C.	N.C.	IP_2	2	VCCINT	VCCINT	AA8
AA19	IP_2	2	IP_2	2	GND	GND	AA19
AC22	N.C.	N.C.	IO_2	2	IO_2	2	AC22
Y3	IP_L54P_3	3	IP_L54P_3	3	IP_3	3	Y3
Y4	IP_L54N_3	3	IP_L54N_3	3	VCCINT	VCCINT	Y4
H4	IP_L12N_3/ VREF_3	3	IP_L12N_3/ VREF_3	3	IP_3/VREF_3	3	H4
G1	IP_L16N_3	3	IP_L16N_3	3	IP_3	3	G1
G2	IP_L16P_3	3	IP_L16P_3	3	GND	GND	G2
G5	IP_L12P_3	3	IP_L12P_3	3	GND	GND	G5
D1	IP_L08N_3	3	IP_L08N_3	3	VCCAUX	VCCAUX	D1
D2	IP_L08P_3	3	IP_L08P_3	3	GND	GND	D2
C1	IP_L04N_3/ VREF_3	3	IP_L04N_3/ VREF_3	3	IP_3/VREF_3	3	C1
C2	IP_L04P_3	3	IP_L04P_3	3	VCCO_3	3	C2
AB3	IP_L62P_3	3	IP_L62P_3	3	GND	GND	AB3
AB4	IP_L62N_3	3	IP_L62N_3	3	VCCAUX	VCCAUX	AB4
AA4	IP_L58P_3	3	IP_L58P_3	3	GND	GND	AA4
AA5	IP_L58N_3/ VREF_3	3	IP_L58N_3/ VREF_3	3	IP_3/VREF_3	3	AA5

Migration Recommendations

There are multiple pinout differences between the XC3SD1800A and the XC3SD3400A FPGAs in the FG676 package. Please note the differences between the two devices from [Table 70](#) and take the necessary precautions.

Revision History

The following table shows the revision history for this document.

Date	Version	Revision
04/02/07	1.0	Initial Xilinx release.
05/25/07	1.1	Updates to Table 59 , Table 63 , Table 64 , Table 65 , Table 66 , Table 67 , Table 68 , Table 69 . Corrected VREF pins in XC3S1800A FG676 (Table 70). Updated FG676 package footprints for XC3SD1800A FPGA (Figure 16) and XC3SD3400A FPGA (Figure 17). Minor edits.
06/18/07	1.2	Updated for Production release.
07/16/07	2.0	Added Low-power options. Added advance thermal data to Table 62 .
06/02/08	2.1	Added Package Overview section. Updated Thermal Characteristics in Table 62 . Corrected name for AB14 in CS484 in Table 63 . Updated links.
03/11/09	2.2	Corrected bank designation for SUSPEND to VCCAUX.
10/04/10	3.0	Revision update to match other data sheet modules.